

SCT2080KE

N-channel SiC power MOSFET

V_{DSS}	1200V
R _{DS(on)} (Typ.)	80 m Ω
I _D	40A
P_D	262W

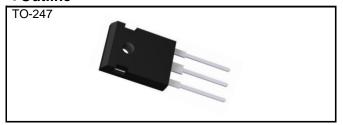
Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating; RoHS compliant

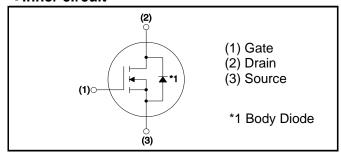
Application

- Solar inverters
- DC/DC converters
- Induction heating
- Motor drives

Outline



•Inner circuit



Packaging specifications

	Packing	Tube
	Reel size (mm)	-
Typo	Tape width (mm)	-
Туре	Basic ordering unit (pcs)	30
	Packing code	С
	Marking	SCT2080KE

● Absolute maximum ratings (T_a = 25°C)

Parameter		Symbol	Value	Unit
Drain - Source voltage		V_{DSS}	1200	V
Continuous drain current	T _c = 25°C	I _D *1	40	А
Continuous drain current	T _c = 100°C	I _D *1	28	А
Pulsed drain current		I _{D,pulse} *2	80	А
Gate - Source voltage (DC)		V_{GSS}	-6 to 22	V
Gate - Source surge voltage (T _{surge} < 300nsec)		V _{GSS-surge} *3	–10 to 26	V
Power dissipation (T _c = 25°C)		P _D	262	W
Junction temperature		T _j	175	°C
Range of storage temperature		T _{stg}	-55 to +175	°C

●Thermal resistance

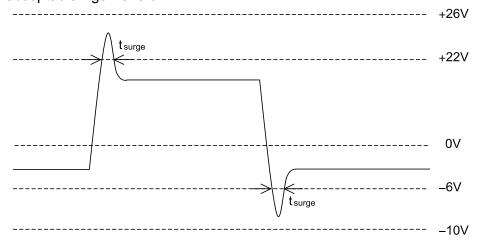
Parameter	Symbol	Values			Unit
- Farameter	Symbol	Min.	Тур.	Max.	Utill
Thermal resistance, junction - case	R_{thJC}	-	0.44	0.57	°C/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	50	°C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	265	°C

●Electrical characteristics (T_a = 25°C)

Parameter	Symbol	Conditions	Values			Unit
raiainetei	Symbol	Conditions	Min.	Тур.	Max.	Offic
Drain - Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V$, $I_D = 1mA$	1200	-	1	V
		$V_{DS} = 1200V, V_{GS} = 0V$				
Zero gate voltage drain current	I _{DSS}	$T_j = 25^{\circ}C$	-	1	10	μΑ
		T _j = 150°C	-	2	-	
Gate - Source leakage current	I _{GSS+}	$V_{GS} = +22V, V_{DS} = 0V$	-	-	100	nA
Gate - Source leakage current	I_{GSS-}	$V_{GS} = -6V, V_{DS} = 0V$	-	-	-100	nA
Gate threshold voltage	V _{GS (th)}	$V_{DS} = V_{GS}$, $I_D = 4.4 \text{mA}$	1.6	2.8	4.0	V

^{*1} Limited only by maximum temperature allowed.

^{*3} Example of acceptable Vgs waveform



*4 Pulsed

^{*2} PW \leq 10 μ s, Duty cycle \leq 1%

●Electrical characteristics (T_a = 25°C)

Parameter	Cymbol	Conditions	Values			Unit
i didilietei	Symbol	Conditions	Min.	Тур.	Max.	Offic
		$V_{GS} = 18V, I_D = 10A$				
Static drain - source on - state resistance	R _{DS(on)} *4	T _j = 25°C	-	80	117	mΩ
		T _j = 125°C	-	125	-	
Gate input resistance	R_{G}	f = 1MHz, open drain	-	6.3	-	Ω
Transconductance	g _{fs} *4	$V_{DS} = 10V, I_{D} = 10A$	-	3.7	-	S
Input capacitance	C _{iss}	V _{GS} = 0V	-	2080	-	
Output capacitance	C _{oss}	V _{DS} = 800V	-	77	-	pF
Reverse transfer capacitance	C _{rss}	f = 1MHz	-	16	-	
Effective output capacitance, energy related	C _{o(er)}	$V_{GS} = 0V$ $V_{DS} = 0V$ to 500V	-	116	-	pF
Turn - on delay time	t _{d(on)} *4	$V_{DD} = 400 \text{V}, \ V_{GS} = 18 \text{V}$	-	35	-	
Rise time	t _r *4	I _D = 10A	-	36	-	20
Turn - off delay time	t _{d(off)} *4	$R_L = 40\Omega$	-	76	-	ns
Fall time	t _f *4	$R_G = 0\Omega$	-	22	ı	
Turn - on switching loss	E _{on} *4	$V_{DD} = 600V, I_{D} = 10A$ $V_{GS} = 18V/0V$	-	174	ı	1
Turn - off switching loss	E _{off} *4	$R_G = 0\Omega$, L=500 μ H *E _{on} includes diode reverse recovery	-	51	ı	μJ

●Gate Charge characteristics (T_a = 25°C)

Parameter	Symbol	Conditions	Values			Unit
raiametei	Symbol	Conditions	Min.	Тур.	Max.	Offic
Total gate charge	Qg *4	V _{DD} = 400V	ı	106	ı	
Gate - Source charge	Q _{gs} *4	I _D = 10A	-	27	ı	nC
Gate - Drain charge	${\sf Q_{gd}}^{^{*4}}$	V _{GS} = 18V	-	31	-	
Gate plateau voltage	V _(plateau)	$V_{DD} = 400V, I_D = 10A$	-	9.7	-	V

●Body diode electrical characteristics (Source-Drain) (T_a = 25°C)

Parameter	Cumbal	Conditions	Values			Unit
raiainetei	Symbol	Conditions	Min.	Тур.	Max.	Unit
Inverse diode continuous, forward current	l _S *1	-T _c = 25°C	1	ı	40	А
Inverse diode direct current, pulsed	I _{SM} *2		-	-	80	А
Forward voltage	V _{SD} *4	$V_{GS} = 0V, I_{S} = 10A$	-	4.6	-	V
Reverse recovery time	t _{rr} *4		-	31	ı	ns
Reverse recovery charge	Q _{rr} *4	$I_F = 10A, V_R = 400V$ di/dt = 150A/µs		44	ı	nC
Peak reverse recovery current	I _{rrm} *4		-	2.3	-	Α

● Typical Transient Thermal Characteristics

Symbol	Value	Unit
R _{th1}	0.078	
R _{th2}	0.197	K/W
R _{th3}	0.162	

Symbol	Value	Unit
C_{th1}	0.005	
C_{th2}	0.018	Ws/K
C _{th3}	0.249	

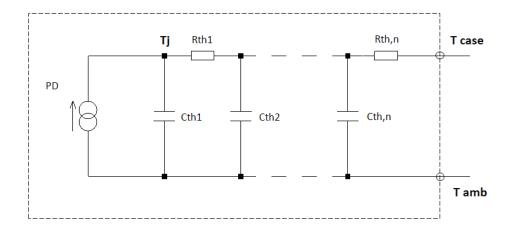


Fig.1 Power Dissipation Derating Curve

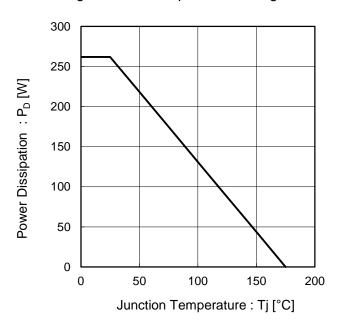
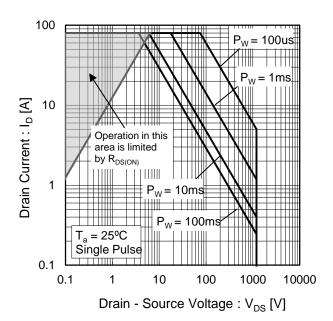


Fig.2 Maximum Safe Operating Area



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Fig.4 Typical Output Characteristics(I)

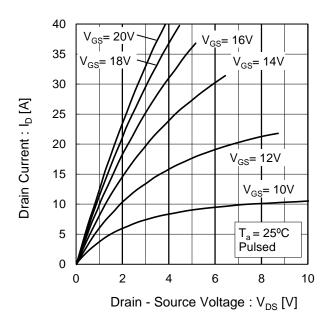


Fig.5 Typical Output Characteristics(II)

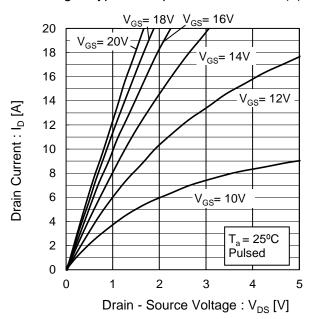


Fig.6 Typical Output Characteristics(I)

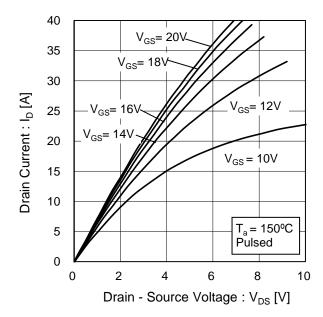


Fig.7 Typical Output Characteristics(II)

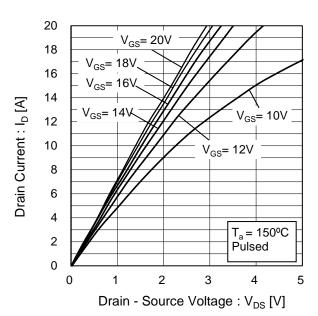


Fig.8 Typical Transfer Characteristics

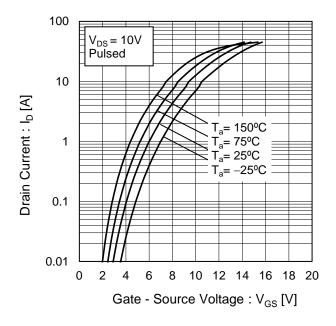


Fig.9 Typical Transfer Characteristics (II)

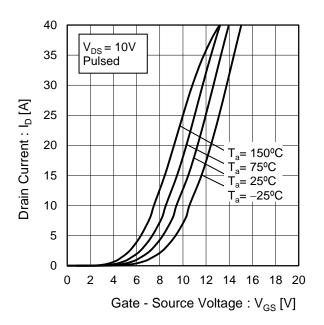


Fig.10 Gate Threshold Voltage vs. Junction Temperature

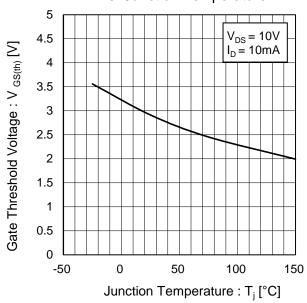


Fig.11 Transconductance vs. Drain Current

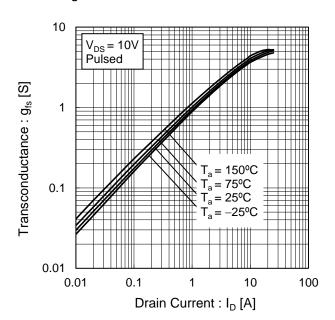


Fig.12 Static Drain - Source On - State Resistance vs. Gate - Source Voltage 8.0 Static Drain - Source On-State Resistance $T_a = 25^{\circ}C$ Pulsed 0.6 $:R_{DS(on)}\left[\Omega \right]$ 0.4 $I_{\rm D} = 20A$ 0.2 $I_D = 10A$ 0 6 8 10 12 14 16 18 20 22 Gate - Source Voltage : V_{GS} [V]

Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature

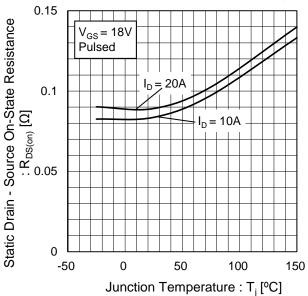
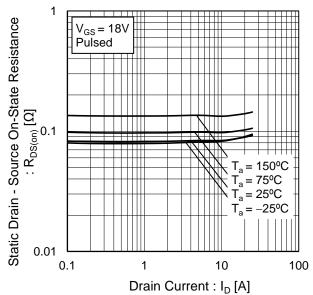


Fig.14 Static Drain - Source On - State Resistance vs. Drain Current



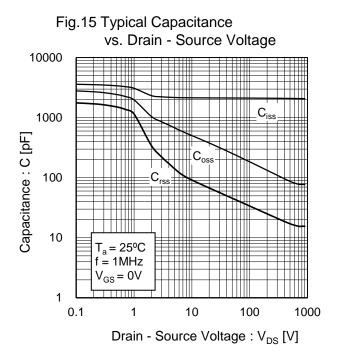


Fig.16 Coss Stored Energy

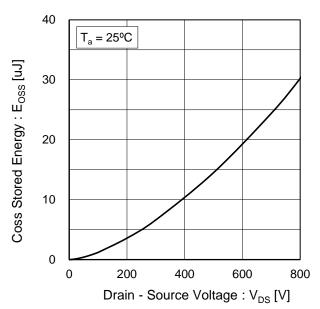


Fig.17 Switching Characteristics

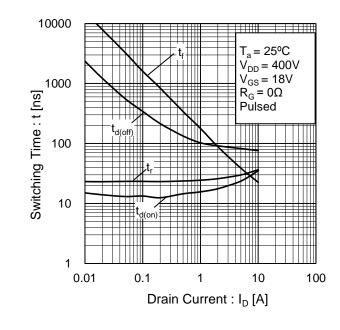
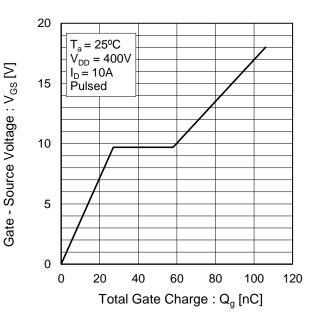
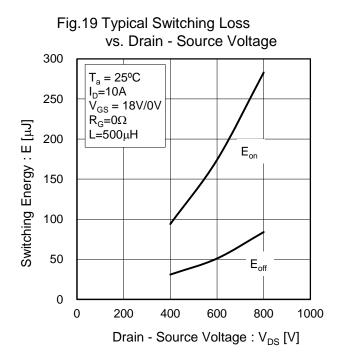
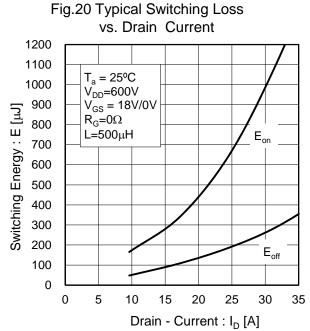
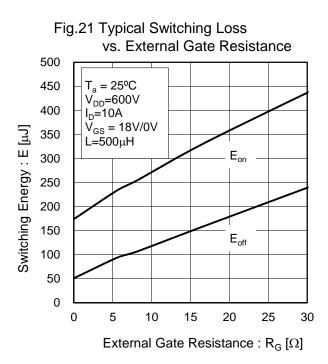


Fig.18 Dynamic Input Characteristics









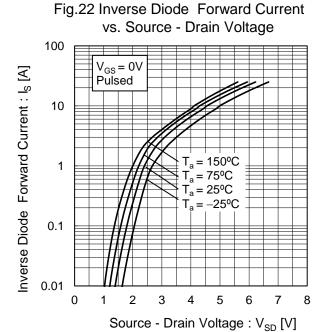


Fig. 23 Reverse Recovery Time vs. Inverse Diode Forward Current

1000 $T_a = 25^{\circ}C$ di / dt = 150A / us $V_{R} = 400V$ $V_{GS} = 0V$ Pulsed

100

1 100

Inverse Diode Forward Current : I_s [A]

●Measurement circuits

Fig.1-1 Switching Time Measurement Circuit

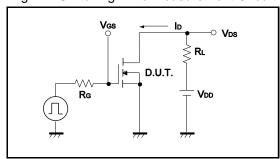


Fig.2-1 Gate Charge Measurement Circuit

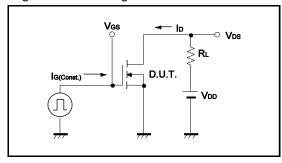


Fig.3-1 Switching Energy Measurement Circuit

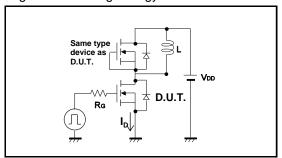


Fig.4-1 Reverse Recovery Time Measurement Circuit Fig.4-2 Reverse Recovery Waveform

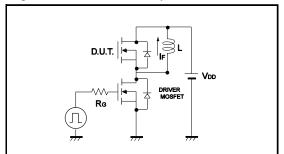


Fig.1-2 Switching Waveforms

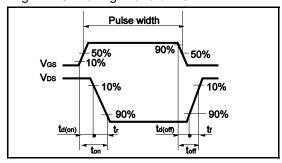


Fig.2-2 Gate Charge Waveform

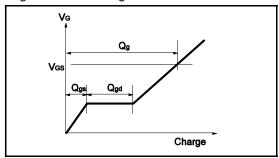
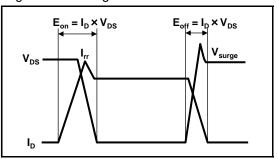
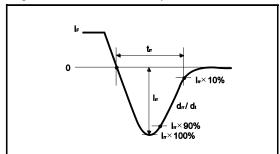


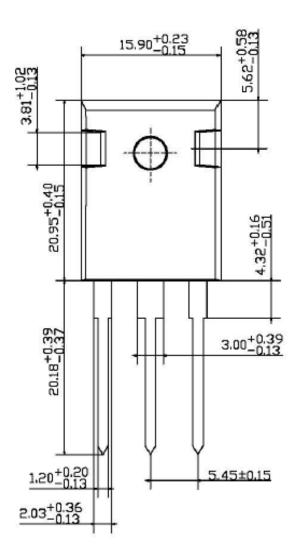
Fig.3-2 Switching Waveforms

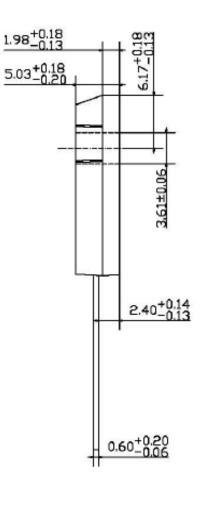


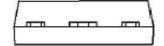


●Dimensions (Unit: mm)

TO-247







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